DT01 Rec'd PCT/PTT 2 5 FEB 2005

			11 1 1 2 2 4	nn2
FORM PTO-1449	SERIAL NO. 10/5	16,002 ·	CASE NO.	
	NOS	ot-essigned	≯ €	20001213
LIST OF PATENTS AND PUBLICATIONS FOR	FILING DATE		GROUP ART	UNIT
APPLICANT'S INFORMATION DISCLOSURE STATEMENT	02/25/2005	Herewith	2825	-NICA
(use several sheets if necessary)	APPLICANT(S): Wolfgang Günther et al			

REFERENCE DESIGNATION U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER Number-Kind Code (If known)	DATE	NAME	CLASS/ SUBCLASS	FILING DATE
ND	A1	5,995,730	November 30, 1999	Blinne		
· · · · ·	<u> </u>					

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER Number-Kind Code (if known)	DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION YES OR NO

EXAMINER INITIAL	(Include name of author, title of the article (when appropriate), title of the item (book, magazine, journal, serial symposium, catalog, etc.), date page(s), volume-issue number(s), publisher, city and/or country where publishe					
W)	A2	Copy of International Examination Report from corresponding PCT patent application No. PCT/EP03/09548.				
W	A3	R. Drechsler, Equivalence Checking of Digital Circuits in an Industrial Environment, IT+TI Informationstech, Tech. Info., Germany, pgs. 200-205, April 2001.				
W	A4	Emmanuel Liégeon, Speed Up ASIC Verification Using Formal Verification, Electronique, No. 122, February 2002.				
W	A5	Subash Chandar G., Addressing Bottlenecks of Fully Synthesized Processor Cores Using Equivalence Checkers, IEEE, pgs. 175-180, 2001.				

EXAMINER	DATE CONSIDERED	. 1 . 1-	
	D7 (12 001101D2112D	611217	
		6 1 W	

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.